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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
December 2022	*	Initial release.

5 Pin Configuration and Functions

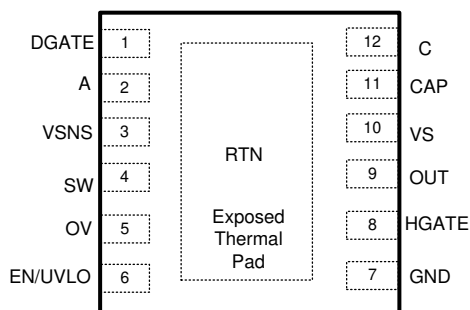


Figure 5-1. DRR Package, 12-Pin WSON (Top View)

Table 5-1. Pin Functions

NAME	PIN		TYPE ⁽¹⁾	DESCRIPTION
	LM74810	WSON		
DGATE	1		O	Diode Controller Gate Drive Output. Connect to the GATE of the external MOSFET. Anode of the ideal diode.
A	2		I	Anode of the ideal diode. Connect to the source of the external MOSFET.
VSNS	3		I	Voltage sensing input.
SW	4		I	Voltage sensing disconnect switch terminal. VSNS and SW are internally connected through a switch. Use SW as the top connection of the battery sensing or OV resistor ladder network. When EN/UVLO is pulled low, the switch is OFF disconnecting the resistor ladder from the battery line thereby cutting off the leakage current. If the internal disconnect switch between VSNS and SW is not used then short them together and connect to VS pin.
OV	5		I	Adjustable overvoltage threshold input. Connect a resistor ladder across SW to OV terminal. When the voltage at OVP exceeds the overvoltage cut-off threshold then the HGATE is pulled low turning OFF the HSFET. HGATE turns ON when the sense voltage goes below the OVP falling threshold.
EN/UVLO	6		I	EN/UVLO Input. Connect to VS pin for always ON operation. Can be driven externally from a micro controller I/O. Pulling it low below $V_{(ENF)}$ makes the device enter into low Iq shutdown mode. For UVLO, connect an external resistor ladder to EN/UVLO to GND.
GND	7		G	Connect to the system ground plane.
HGATE	8		O	GATE driver output for the HSFET. Connect to the GATE of the external FET.
OUT	9		I	Connect to the output rail (external MOSFET source).
VS	10		I	Input power supply to the IC. Connect VS to middle point of the common drain back to back MOSFET configuration. Connect a 100nF capacitor across VS and GND pins.
CAP	11		O	Charge pump output. Connect a 100-nF capacitor across CAP and VS pins.
C	12		I	Cathode of the ideal diode. Connect to the drain of the external MOSFET.
RTN	Thermal Pad		—	Leave exposed pad floating. Do not connect to GND plane.

(1) I = input, O = output, I/O = input and output, P = power, G = Ground

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Input Pins	A to GND	–65	70	V
	VS to GND	–1	70	
	VSNS, SW, EN/UVLO, C, OV, OUT to GND, $V_{(A)} > 0$ V	–0.3	70	
	VSNS, SW, EN/UVLO, C, OV, OUT to GND, $V_{(A)} \leq 0$ V	$V_{(A)}$	$(70 + V_{(A)})$	
	RTN to GND	–65	0.3	
	I_{VSNS} , I_{SW}	–1	10	mA
	$I_{EN/UVLO}$, I_{OV} , $V_{(A)} > 0$ V	–1		mA
	$I_{EN/UVLO}$, I_{OV} , $V_{(A)} \leq 0$ V	Internally limited		
Output Pins	OUT to VS	–65	16.5	V
Output Pins	CAP to VS	–0.3	15	V
	CAP to A	–0.3	85	
	DGATE to A	–0.3	15	
	HGATE to OUT	–0.3	15	
Output to Input Pins	C to A	–5	85	
Operating junction temperature, T_j ⁽²⁾		–55	150	°C
Storage temperature, T_{stg}		–55	150	

- (1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) High junction temperatures degrade operating lifetimes. Operating lifetime is de-rated for junction temperatures greater than 125°C.

6.2 ESD Ratings

				VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per JEDEC JS-001 ⁽¹⁾		±2000	V
		Charged device model (CDM), V per JEDEC JS-002 ⁽²⁾	Corner pins (DGATE, OV, and C)	±750	
			Other pins	±500	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP155 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	NOM	MAX	UNIT
Input Pins	A to GND	–60		65	V
	VS to GND	0		65	V
	EN/UVLO to GND	0		65	V
External Capacitance	CAP to A, VS to GND, A to GND	0.1			μF
External MOSFET max VGS rating	DGATE to A and HGATE to OUT	15			V
T_j	Operating Junction temperature ⁽²⁾	–55		150	°C

- (1) Recommended Operating Conditions are conditions under which the device is intended to be functional. For specifications and test conditions, see Electrical Characteristics.
- (2) High junction temperatures degrade operating lifetimes. Operating lifetime is de-rated for junction temperatures greater than 125°C.

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		LM74810	UNIT
		DRR (WSON)	
		12 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	60.9	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	48	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	31.5	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	1.2	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	31.4	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	7.1	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Electrical Characteristics

$T_J = -55^{\circ}\text{C}$ to $+125^{\circ}\text{C}$; typical values at $T_J = 25^{\circ}\text{C}$, $V_{(A)} = V_{(OUT)} = V_{(VS)} = V_{(VSNS)} = 12\text{ V}$, $V_{(AC)} = 20\text{ mV}$, $C_{(VCAP)} = 0.1\text{ }\mu\text{F}$, $V_{(EN/UVLO)} = 2\text{ V}$, over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY VOLTAGE						
V _(VS)	Operating input voltage		3		65	V
V _(VS_PORR)	VS POR threshold, rising		2.4	2.6	2.85	V
V _(VS_PORF)	VS POR threshold, falling		1.9	2.1	2.3	V
I _(SHDN)	SHDN current, I _(GND)	V _(EN/UVLO) = 0 V		2.87	5	μA
I _(Q)	Total System Quiescent current, I _(GND)	V _(EN/UVLO) = 2 V		397		μA
		V _(A) = V _(VS) = 24 V, V _(EN/UVLO) = 2 V		413	530	μA
I _(REV)	I _(A) leakage current during Reverse Polarity,	0 V ≤ V _(A) ≤ − 65 V		10	112	μA
	I _(OUT) leakage current during Reverse Polarity				1	μA
ENABLE AND UNDERVOLTAGE LOCKOUT (EN/UVLO) INPUT						
V _(UVLOR)	EN/UVLO threshold voltage, rising		1.195	1.231	1.267	V
V _(UVLOF)	EN/UVLO threshold voltage, falling		1.091	1.132	1.159	V
V _(ENF)	Enable threshold voltage for low Iq shutdown, falling		0.3	0.67	0.93	V
V _(EN_Hys)	Enable Hysteresis		37	72	95	mV
I _(EN/UVLO)		0 V ≤ V _(EN/UVLO) ≤ 65 V		55	200	nA
OVERVOLTAGE PROTECTION AND BATTERY SENSING (VSNS, SW, OV) INPUT						
R _(SW)	Battery sensing disconnect switch resistance	3 V ≤ V _(SNS) ≤ 65 V	10	19.5	46	Ω
V _(OVR)	Overvoltage threshold input, rising		1.195	1.231	1.267	V
V _(OVF)	Overvoltage threshold input, falling		1.091	1.13	1.159	V
I _(OV)	OV Input leakage current	0 V ≤ V _(OV) ≤ 65 V		53	200	nA
CHARGE PUMP (CAP)						
I _(CAP)	Charge Pump source current (Charge pump on)	V _(CAP) − V _(A) = 7 V, 6 V ≤ V _(S) ≤ 65 V	2.5	3.8		mA
VCAP − VS	Charge Pump Turn ON voltage		11	12.2	13.2	V
	Charge Pump Turnoff voltage		11.9	13.2	14.1	V

6.5 Electrical Characteristics (continued)

$T_J = -55^{\circ}\text{C}$ to $+125^{\circ}\text{C}$; typical values at $T_J = 25^{\circ}\text{C}$, $V_{(A)} = V_{(OUT)} = V_{(VS)} = V_{(VSNS)} = 12\text{ V}$, $V_{(AC)} = 20\text{ mV}$, $C_{(VCAP)} = 0.1\text{ }\mu\text{F}$, $V_{(EN/UVLO)} = 2\text{ V}$, over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{(CAP\text{ UVLO})}$	Charge Pump UVLO voltage threshold, rising		5.4	6.6	7.9	V
	Charge Pump UVLO voltage threshold, falling		4.4	5.5	6.6	V
IDEAL DIODE (A, C, DGATE)						
$V_{(A_PORR)}$	$V_{(A)}$ POR threshold, rising		2.2	2.35	2.6	V
$V_{(A_PORF)}$	$V_{(A)}$ POR threshold, falling		2	2.2	2.4	V
$V_{(AC_REG)}$	Regulated Forward $V_{(A)}-V_{(C)}$ Threshold		5.8	9.1	12.4	mV
$V_{(AC_REV)}$	$V_{(A)}-V_{(C)}$ Threshold for Fast Reverse Current Blocking		-6.5	-5.5	-1.3	mV
$V_{(AC_FWD)}$	$V_{(A)}-V_{(C)}$ Threshold for Reverse to Forward transition		150	177	220	mV
$V_{(DGATE)} - V_{(A)}$	Gate Drive Voltage	$3\text{ V} < V_{(S)} < 5\text{ V}$	7			V
		$5\text{ V} < V_{(S)} < 65\text{ V}$	10	11.5	13	V
$I_{(DGATE)}$	Peak Gate Source current	$V_{(A)} - V_{(C)} = 100\text{ mV}$, $V_{(DGATE)} - V_{(A)} = 1\text{ V}$		60		mA
	Peak Gate Sink current	$V_{(A)} - V_{(C)} = -12\text{ mV}$, $V_{(DGATE)} - V_{(A)} = 11\text{ V}$		2670		mA
$I_{(DGATE)}$	Regulation sink current	$V_{(A)} - V_{(C)} = 0\text{ V}$, $V_{(DGATE)} - V_{(A)} = 11\text{ V}$	8.4	14.9		μA
$I_{(C)}$	Cathode leakage Current	$V_{(A)} = -14\text{ V}$, $V_{(C)} = 12\text{ V}$	4	9	32	μA
HIGH SIDE CONTROLLER (HGATE, OUT, SNS, SW, OV)						
$V_{(HGATE)} - V_{(OUT)}$	Gate Drive Voltage	$3\text{ V} < V_{(S)} < 5\text{ V}$	7			V
		$5\text{ V} < V_{(S)} < 65\text{ V}$	10	11.1	14.5	V
$I_{(HGATE)}$	Source Current		39	55	75	μA
	Sink Current	$V_{(OV)} > V_{(OVR)}$	168	260		mA

6.6 Switching Characteristics

$T_J = -55^{\circ}\text{C}$ to $+125^{\circ}\text{C}$; typical values at $T_J = 25^{\circ}\text{C}$, $V_{(A)} = V_{(C)} = V_{(OUT)} = V_{(VS)} = 12\text{ V}$, $V_{(AC)} = 20\text{ mV}$, $C_{(VCAP)} = 0.1\text{ }\mu\text{F}$, $V_{(EN/UVLO)} = 2\text{ V}$, over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{\text{DGATE_OFF(dly)}}$	DGATE Turnoff Delay during reverse voltage detection	$V_{(A)} - V_{(C)} = +30\text{ mV}$ to -100 mV to $V_{(DGATE-A)} < 1\text{ V}$, $C_{(DGATE-A)} = 10\text{ nF}$		0.5	0.875	μs
$t_{\text{DGATE_ON(dly)}}$	DGATE Turnon Delay during forward voltage detection	$V_{(A)} - V_{(C)} = -20\text{ mV}$ to $+700\text{ mV}$ to $V_{(DGATE-A)} > 5\text{ V}$, $C_{(DGATE-A)} = 10\text{ nF}$		0.8	1.6	μs
$t_{\text{EN(dly)_DGATE}}$	DGATE Turnon Delay during EN/UVLO	EN/UVLO \uparrow to $V_{(DGATE-A)} > 5\text{ V}$, $C_{(DGATE-A)} = 10\text{ nF}$	98	175	270	μs
$t_{\text{EN_OFF(deg)_DGATE}}$	DGATE Turnoff Deglitch during EN/UVLO	EN/UVLO \downarrow to DGATE \downarrow		8.1		μs
$t_{\text{EN_OFF(deg)_HGATE}}$	HGATE Turnoff Deglitch during EN/UVLO	EN/UVLO \downarrow to HGATE \downarrow	3	4.6	6	μs
$t_{\text{OVP_OFF(deg)_HGATE}}$	HGATE Turnoff Deglitch during OV	OV \uparrow to HGATE \downarrow		3.98	5.4	μs
$t_{\text{OVP_ON(deg)_HGATE}}$	HGATE Turnon Deglitch during OV	OV \downarrow to HGATE \uparrow		2.95		μs

6.7 Typical Characteristics

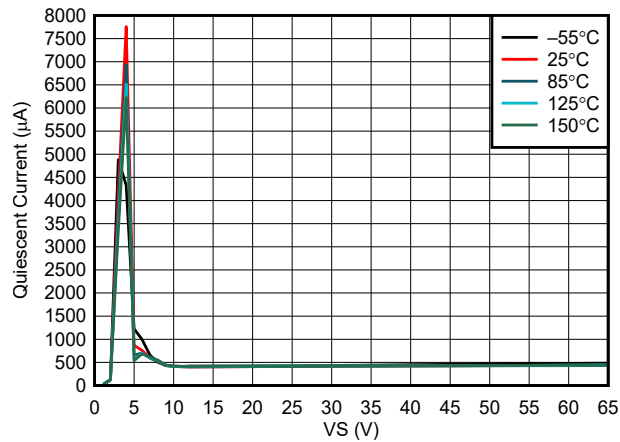


Figure 6-1. Operating Quiescent Current vs Supply Voltage

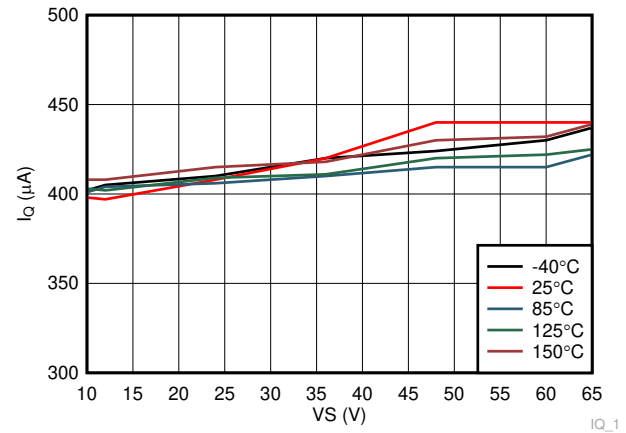


Figure 6-2. Operating Quiescent Current vs Supply Voltage (> 10 V)

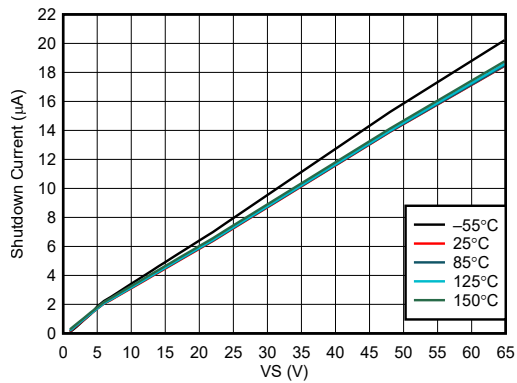


Figure 6-3. Shutdown Supply Current vs Supply Voltage

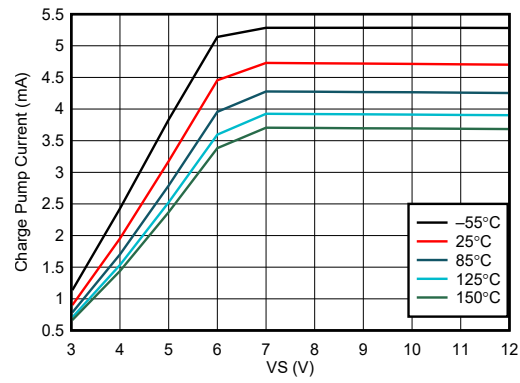


Figure 6-4. Charge Pump Current vs Supply Voltage at CAP = 6 V

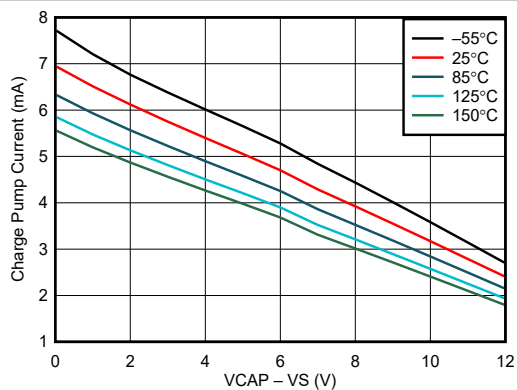


Figure 6-5. Charge Pump V-I Characteristics at VS ≥ 12 V

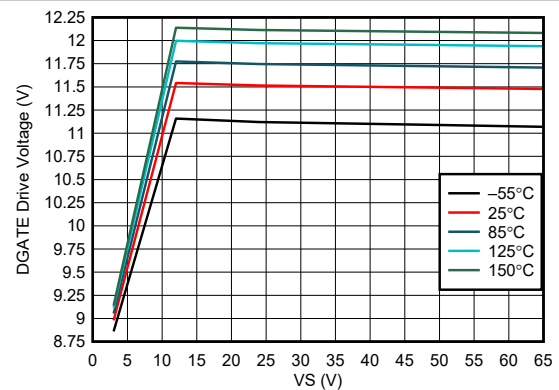


Figure 6-6. DGATE Drive Voltage vs Supply Voltage

6.7 Typical Characteristics (continued)

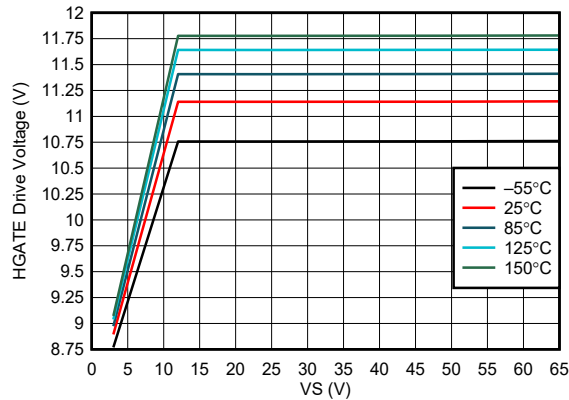


Figure 6-7. HGATE Drive Voltage vs Supply Voltage

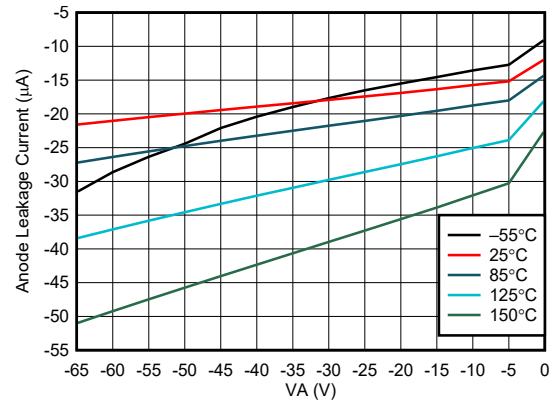


Figure 6-8. ANODE Leakage Current vs Reverse ANODE Voltage

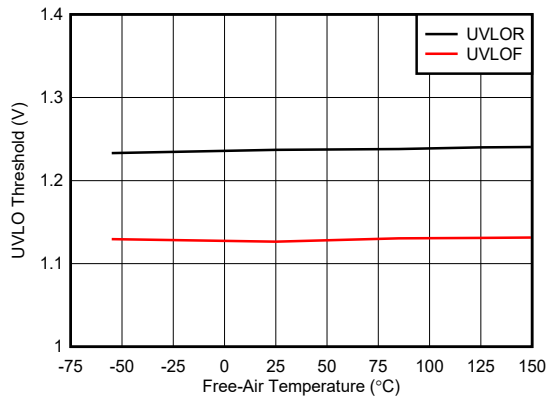


Figure 6-9. UVLO Thresholds vs Temperature

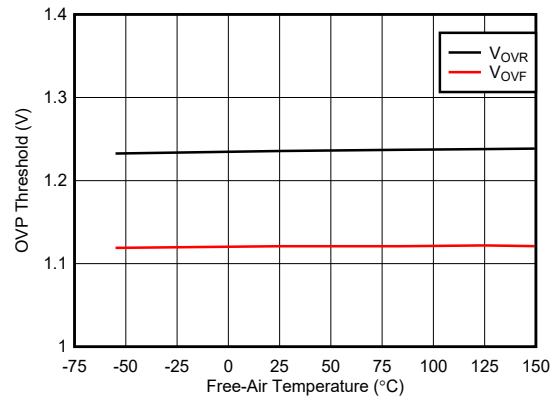


Figure 6-10. OVP Thresholds vs Temperature

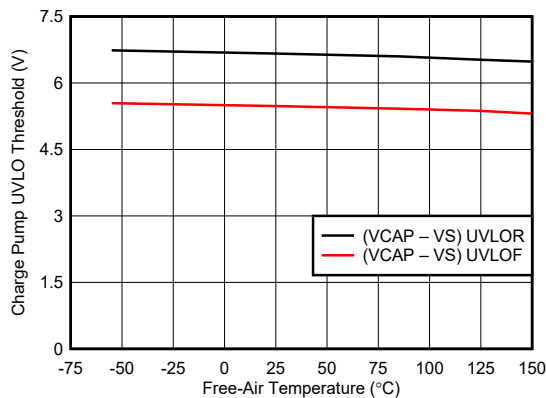


Figure 6-11. Charge Pump UVLO Threshold vs Temperature

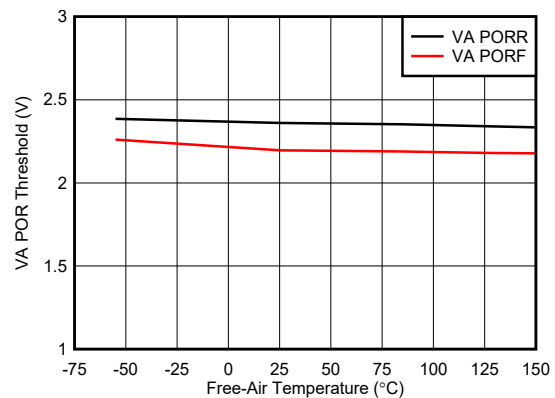


Figure 6-12. VA POR Threshold vs Temperature

6.7 Typical Characteristics (continued)

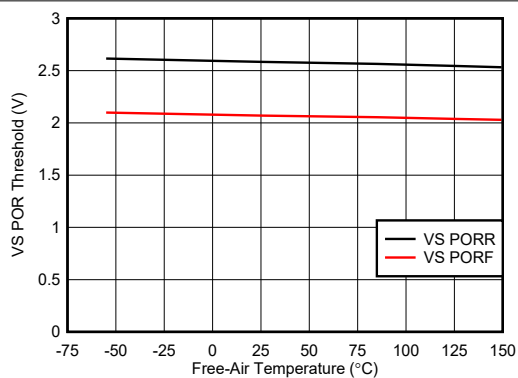


Figure 6-13. VS POR Threshold vs Temperature

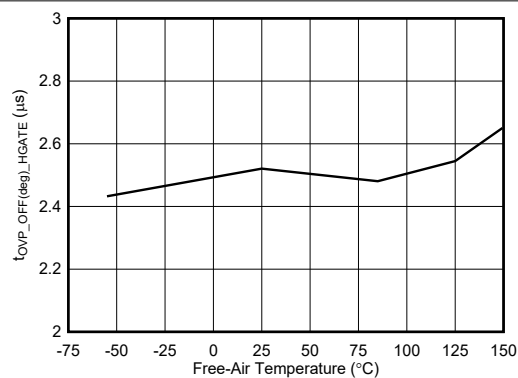


Figure 6-14. HGATE Turn OFF Delay During OV

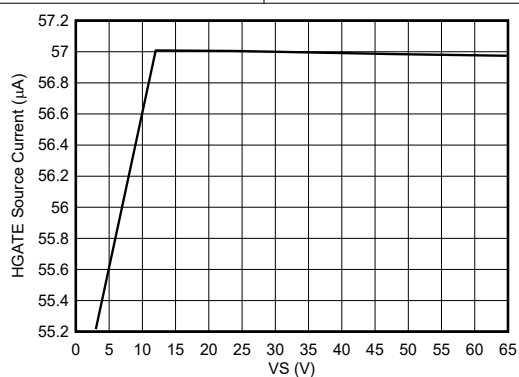


Figure 6-15. HGATE Current (IHGATE) vs Supply Voltage

7 Parameter Measurement Information

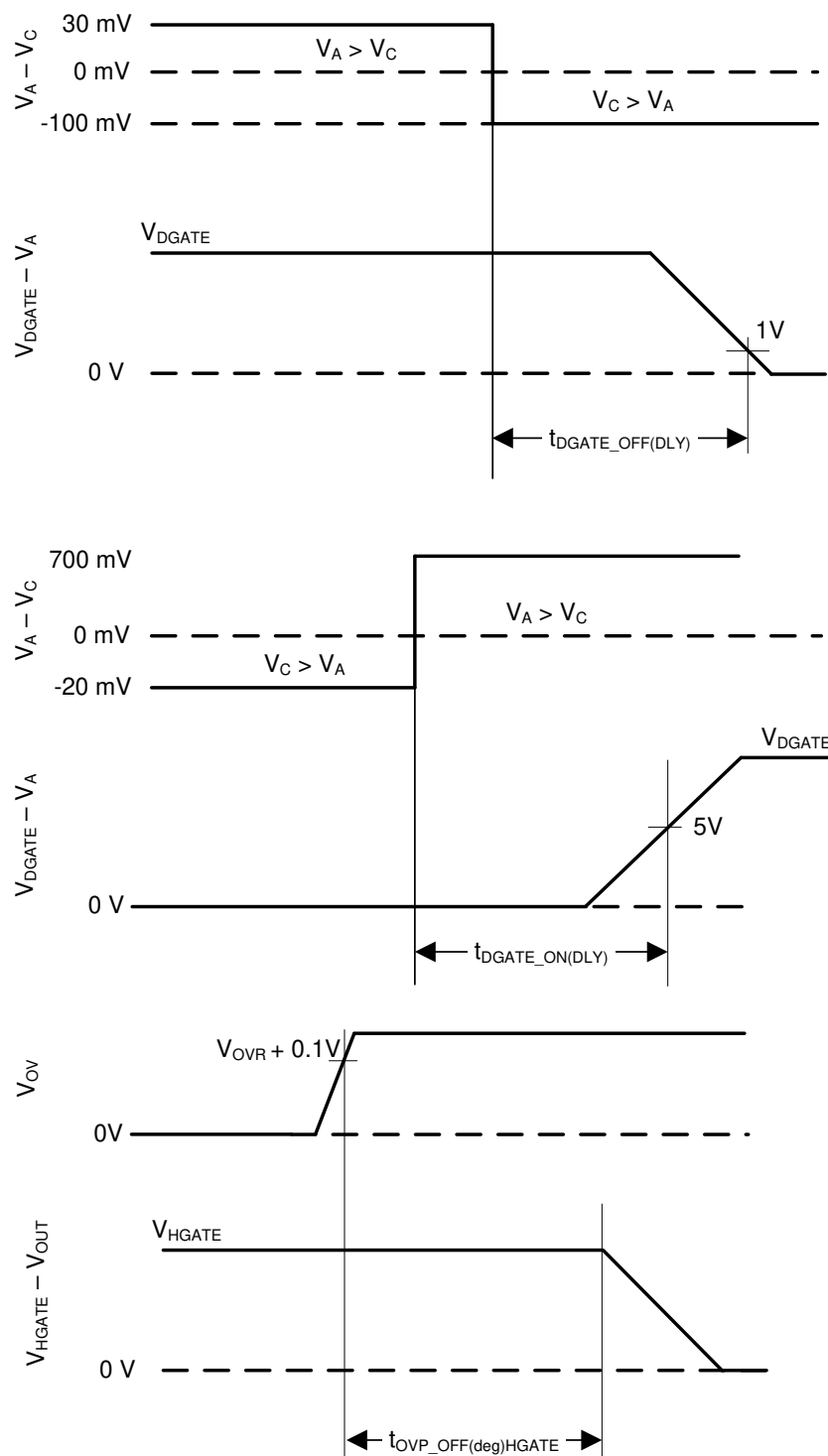


Figure 7-1. Timing Waveforms

8 Detailed Description

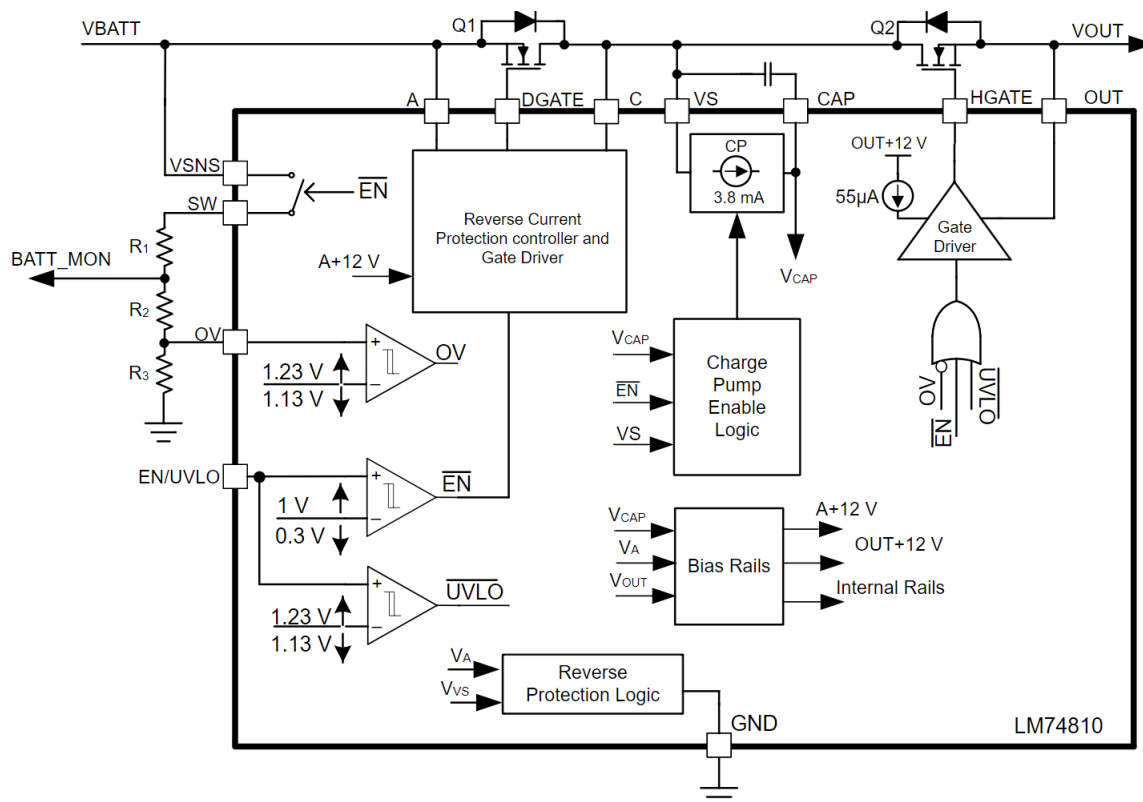
8.1 Overview

The LM74810 ideal diode controller drives and controls external back to back N-Channel MOSFETs to emulate an ideal diode rectifier with power path ON/OFF control, inrush current limiting and overvoltage protection. The wide input supply of 3 V to 65 V allows protection and control of 12-V and 24-V automotive battery powered ECUs. The device can withstand and protect the loads from negative supply voltages down to -65 V. An integrated ideal diode controller (DGATE) drives the first MOSFET to replace a Schottky diode for reverse input protection and output voltage holdup. A strong charge pump with 60-mA peak GATE source current driver stage and short turn ON and turn OFF delay times ensures fast transient response ensuring robust performance during automotive testing such as ISO16750 or LV124 where an ECU is subjected to AC superimpose input signals upto 200-KHz frequency. With a second MOSFET in the power path the device allows load disconnect (ON/OFF control) and overvoltage protection using HGATE control. The device features an adjustable overvoltage cut-off protection feature using a programming resistor across SW and OVP terminal.

The LM74810 controls the DGATE of the MOSFET to regulate the forward voltage drop at 9.1 mV. The linear regulation scheme in these devices enables graceful control of the GATE voltage and turns off of the MOSFET during a reverse current event and ensures zero DC reverse current flow.

The device features enable control. With the enable pin low during the standby mode, both the external MOSFETs and controller is off and draws a very low 2.87 μ A of current. The high voltage rating of LM74810 helps to simplify the system designs for automotive ISO7637 protection. The LM74810 are also suitable for ORing applications.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Charge Pump

The charge pump supplies the voltage necessary to drive the external N-channel MOSFET. An external charge pump capacitor is placed between CAP and VS pins to provide energy to turn on the external MOSFET. In order for the charge pump to supply current to the external capacitor the EN/UVLO pin voltage must be above the specified input high threshold, $V_{(ENR)}$. When enabled, the charge pump sources a charging current of 3.8-mA typical. If EN/UVLO pin is pulled low, then the charge pump remains disabled. To ensure that the external MOSFET can be driven above its specified threshold voltage, the CAP to VS voltage must be above the undervoltage lockout threshold, typically 6.6 V, before the internal gate driver is enabled. Use Equation 1 to calculate the initial gate driver enable delay.

$$T_{(DRV_EN)} = 175\mu s + C_{(CAP)} \times \frac{V_{(CAP_UVLOR)}}{3.8mA} \quad (1)$$

where

- $C_{(CAP)}$ is the charge pump capacitance connected across VS and CAP pins
- $V_{(CAP_UVLOR)} = 6.6\text{ V}$ (typical)

To remove any chatter on the gate drive approximately 1 V of hysteresis is added to the VCAP undervoltage lockout. The charge pump remains enabled until the CAP to VS voltage reaches 13.2 V, typically, at which point the charge pump is disabled decreasing the current draw on the VS pin. The charge pump remains disabled until the CAP to VS voltage is below to 12.2 V typically at which point the charge pump is enabled. The voltage between CAP and VS continue to charge and discharge between 12.2 V and 13.2 V as shown in Figure 8-1. By enabling and disabling the charge pump, the operating quiescent current of the LM74810 is reduced. When the charge pump is disabled it sinks 15 μA .

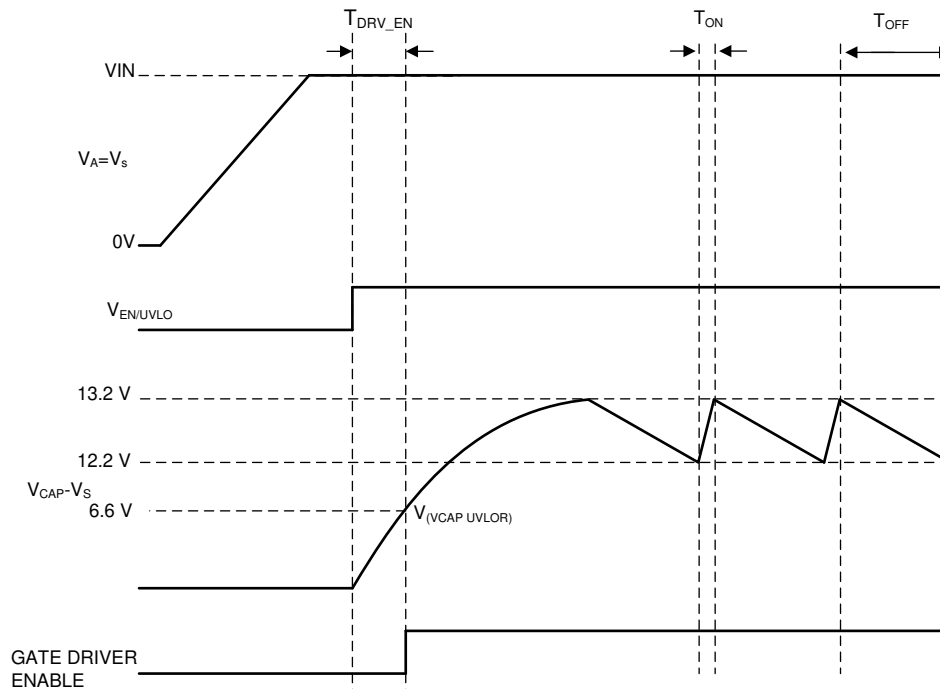


Figure 8-1. Charge Pump Operation

8.3.2 Dual Gate Control (DGATE, HGATE)

The LM74810 features two separate gate control and driver outputs to drive back to back N-channel MOSFETs.

8.3.2.1 Reverse Battery Protection (A, C, DGATE)

A, C, DGATE comprises of Ideal Diode stage. Connect the Source of the external MOSFET to A, Drain to C and Gate to DGATE. The LM74810 has integrated reverse input protection down to -65 V .

Before the DGATE driver is enabled, following conditions must be achieved:

- The EN/UVLO pin voltage must be greater than the specified input high voltage.
- The CAP to VS voltage must be greater than the undervoltage lockout voltage.
- Voltage at A pin must be greater than VA POR Rising threshold.
- Voltage at Vs pin must be greater than Vs POR Rising threshold.

If the above conditions are not achieved, then the DGATE pin is internally connected to the A pin, assuring that the external MOSFET is disabled.

In LM74810 the voltage drop across the MOSFET is continuously monitored between the A and C pins, and the DGATE to A voltage is adjusted as needed to regulate the forward voltage drop at 9.1 mV (typ). This closed loop regulation scheme enables graceful turn off of the MOSFET during a reverse current event and ensures zero DC reverse current flow. This scheme ensures robust performance during slow input voltage ramp down tests. Along with the linear regulation amplifier scheme, the LM74810 also integrates a fast reverse voltage comparator. When the voltage drop across A and C reaches $V_{(AC_REV)}$ threshold then the DGATE goes low within 0.5- μ s (typ). This fast reverse voltage comparator scheme ensures robust performance during fast input voltage ramp down tests such as input micro-shorts. The external MOSFET is turned ON back when the voltage across A and C hits $V_{(AC_FWD)}$ threshold within 0.85 μ s (typ).

For Ideal Diode only designs, connect LM74810 as shown in [Figure 8-2](#).

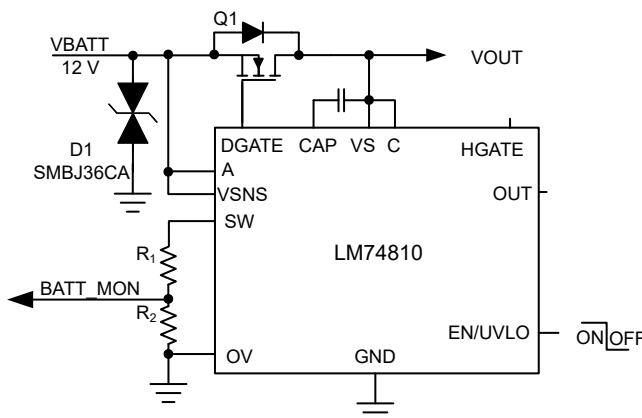


Figure 8-2. Configuring LM74810 for Ideal Diode Only

8.3.2.2 Load Disconnect Switch Control (HGATE, OUT)

HGATE and OUT comprises of Load disconnect switch control stage. Connect the Source of the external MOSFET to OUT and Gate to HGATE.

Before the HGATE driver is enabled, following conditions must be achieved:

- The EN/UVLO pin voltage must be greater than the specified input high voltage.
- The CAP to VS voltage must be greater than the undervoltage lockout voltage.
- Voltage at Vs pin must be greater than Vs POR Rising threshold.

If the above conditions are not achieved, then the HGATE pin is internally connected to the OUT pin, assuring that the external MOSFET is disabled.

For Inrush Current limiting, connect C_{dVdT} capacitor and R_1 as shown in [Figure 8-3](#).

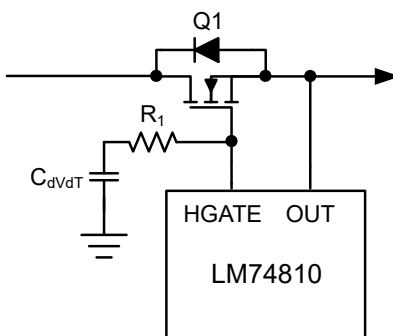


Figure 8-3. Inrush Current Limiting

The C_{dVdT} capacitor is required for slowing down the HGATE voltage ramp during power up for inrush current limiting. Use Equation 2 to calculate C_{dVdT} capacitance value.

$$C_{dVdT} = \frac{I_{HGATE_DRV}}{I_{INRUSH}} \times C_{OUT} \quad (2)$$

where I_{HGATE_DRV} is 55 μA (typ), I_{INRUSH} is the inrush current and C_{OUT} is the output load capacitance. An extra resistor, R_1 , in series with the C_{dVdT} capacitor improves the turn off time.

8.3.3 Overvoltage Protection and Battery Voltage sensing (VSNS, SW, OV)

Connect a resistor ladder as shown in Figure 8-4 for Overvoltage threshold programming.

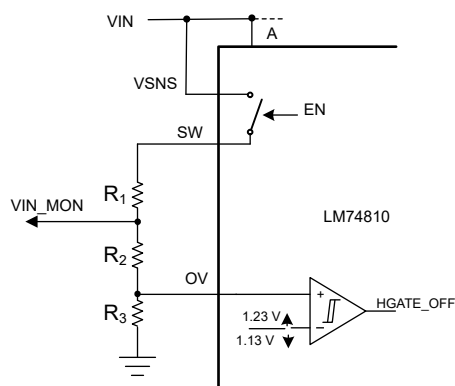


Figure 8-4. Programming Overvoltage Threshold and Battery Sensing

A disconnect switch is integrated between VSNS and SW pins. This switch is turned OFF when EN/UVLO pin is pulled low. This helps to reduce the leakage current through the resistor divider network during system shutdown state (IGN_OFF state).

8.3.4 Low Iq Shutdown and Undervoltage Lockout (EN/UVLO)

The enable pin allows for the gate driver to be either enabled or disabled by an external signal. If the EN/UVLO pin voltage is greater than the rising threshold, the gate driver and charge pump operates as described in Charge Pump section. If EN/UVLO pin voltage is less than the input low threshold, $V_{(ENF)}$, the charge pump and both the gate drivers (DGATE and HGATE) are disabled placing the LM74810 in shutdown mode.

If $V_{(ENF)} < V_{(EN/UVLO)} < V_{(UVLOF)}$ then only HGATE is disabled disconnecting the load from the supply, DGATE remains ON.

The EN/UVLO pin can withstand a maximum voltage of 65 V. For always ON operation connect EN/UVLO pin to VS.

8.4 Device Functional Modes

The LM74810 enters shutdown mode when the EN/UVLO pin voltage is below the specified input low threshold $V_{(ENF)}$. Both the gate drivers and the charge pump are disabled in shutdown mode. During shutdown mode the LM74810 enters low IQ operation with a total input quiescent consumption of 2.87 μA (typ). When the LM74810 is in shutdown mode, forward current flow to always ON loads connected to the common drain point of the back to back MOSFETs is not interrupted but is conducted through the MOSFET's body diode.

8.5 Application Examples

8.5.1 Redundant Supply OR-ing With Inrush Current Limiting, Overvoltage Protection and ON/OFF Control

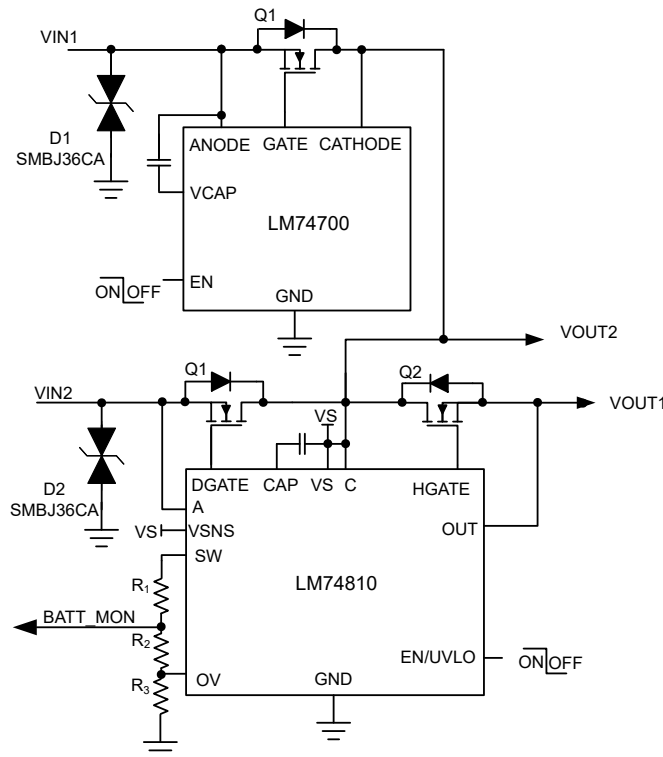


Figure 8-5. Redundant Supply OR-ing With Overvoltage Protection and ON/OFF Control

Figure 8-5 shows the implementation of dual OR-ing with inrush current limiting, overvoltage protection and power path ON/OFF control. The input side SMBJ36CA TVS across the ideal diodes is required for ISO7637 Pulse 1 transient suppression to limit the input voltage within the device max voltage rating of -65 V .

R1 and R2 are the programming resistors for overvoltage protection (OVP) threshold. When the voltage at OVP pin exceeds OVP cut-off reference threshold then the HGATE driver turns OFF the FET Q3, disconnecting the power path and protecting the downstream load. HGATE goes high once the OVP pin voltage goes below the OVP falling hysteresis threshold. Use 0.1- μ F to 1- μ F capacitor across VS to CAP pins of the LM74810. This is the charge pump capacitor and acts as the supply for both the DGATE and HGATE driver stages. The DGATE driver of the LM74810 is equipped with 60-mA peak source current and 1.5-A peak sink current capability resulting in fast and efficient transient responses during the ISO16750 or LV124 short interruptions as well as AC superimpose testing.

Pull EN low during the sleep/standby mode. With EN low, both the DGATE and HGATE drivers are pulled low turning OFF both the power FETs. VOUT1 gets disconnected from the VBATT rail reducing the system I_Q. VOUT2 is gets power through the body diode of the MOSFET Q2 and this supply can be utilized for always ON loads. The LM74810 draws a 2.87- μ A current during this mode.

9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

LM74810 controls two N-channel power MOSFETs with DGATE used to control diode MOSFET to emulate an ideal diode and HGATE controlling second MOSFET for power path cut-off when disabled or during an overvoltage protection. HGATE controlled MOSFET can be used to clamp the output during overvoltage or load dump conditions. LM74810 can be placed into low quiescent current mode using EN/UVLO, where both DGATE and HGATE are turned OFF.

9.2 Typical 12-V Reverse Battery Protection Application

A typical application circuit of LM74810 configured to provide reverse battery protection with overvoltage protection is shown in [Figure 9-1](#).

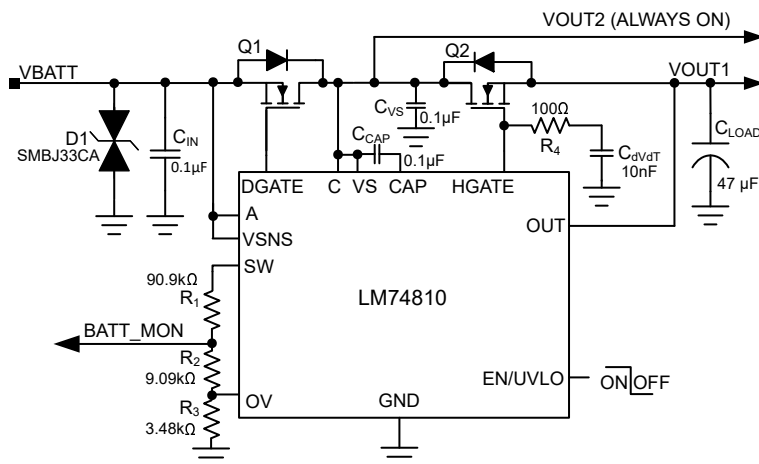


Figure 9-1. Typical Application Circuit for 12-V Reverse Battery Protection and Overvoltage Protection

9.2.1 Design Requirements for 12-V Battery Protection

The system design requirements are listed in [Table 9-1](#).

Table 9-1. Design Parameters - 12-V Reverse Battery Protection and Overvoltage Protection

DESIGN PARAMETER	EXAMPLE VALUE
Operating Input Voltage Range	12-V battery, 12-V nominal with 3.2-V Cold Crank and 35-V Load Dump
Output Power	200 W
Output Current Range	12-A Nominal, 18-A maximum
Input Capacitance	0.1-µF minimum
Output Capacitance	0.1-µF minimum, (optional hold-up capacitor 470 µF)
Overvoltage Cut-off	37.0 V, output cut-off >37.0 V
Battery Monitor Ratio	8:1

9.2.2 Automotive Reverse Battery Protection

The LM74810 feature two separate gate control and driver outputs (DGATE and HGATE) to drive back to back N-channel MOSFETs. This enables LM74810 to provide comprehensive immunity with robust system protection

during various automotive transient tests as per ISO 7637-2 and ISO 16750-2 standard as well as other automotive OEM standards. For more information, see the [Automotive EMC-compliant reverse-battery protection with ideal-diode controllers](#) article.

LM74810 gate drive output DGATE controls MOSFET Q1 to provide reverse battery protection and true reverse current blocking functionality. HGATE controls MOSFET Q2 to turn off the power path during input overvoltage condition. Resistor network R1, R2 and R3 connected to OV and SW can be configured for overvoltage protection and also for battery monitoring under normal operating conditions as well as reverse battery conditions. Bi-directional TVS D1 clamps the automotive transient input voltages on the 12-V battery, both positive and negative transients, to voltage levels safe for MOSFET Q1 and LM74810.

Fast reverse current blocking response and quick reverse recovery enables LM74810 to turn ON/OFF MOSFET Q1 during AC super imposed input and provide active rectification of the AC input superimposed on DC battery voltage. Fast reverse current blocking response of LM74810 helps to turn off MOSFET Q1 during negative transients inputs and input micro short interruption conditions where input can fall to 0-V for short duration.

9.2.3 Detailed Design Procedure

9.2.3.1 Design Considerations

Table 9-1 summarizes the design parameters that must be known for designing an automotive reverse battery protection circuit with overvoltage cut-off. During power up, inrush current through MOSFET Q2 needs to be limited so that the MOSFET operates well within its SOA. Maximum load current, maximum ambient temperature and thermal properties of the PCB determine the $R_{DS(on)}$ of the MOSFET Q2 and maximum operating voltage determines the voltage rating of the MOSFET Q2. Selection of MOSFET Q2 is determined mainly by the maximum operating load current, maximum ambient temperature, maximum frequency of AC super imposed voltage ripple and ISO 7637-2 pulse 1 requirements. Overvoltage threshold is decided based on the rating of downstream DC/DC converter or other components after the reverse battery protection circuit. A single bi-directional TVS or two back-back uni-directional TVS are required to clamp input transients to a safe operating level for the MOSFETs Q1, Q2 and LM74810.

9.2.3.2 Charge Pump Capacitance VCAP

Minimum required capacitance for charge pump VCAP is based on input capacitance of the MOSFET Q1, $C_{ISS(MOSFET_Q1)}$ and input capacitance of Q2 $C_{ISS(MOSFET)}$.

Charge Pump VCAP: Minimum 0.1 μF is required; recommended value of VCAP (μF) $\geq 10 \times (C_{ISS(MOSFET_Q1)} + C_{ISS(MOSFET_Q2)})$ (μF).

9.2.3.3 Input and Output Capacitance

A minimum input capacitance C_{IN} of 0.1 μF and output capacitance C_{OUT} of 0.1 μF is recommended.

9.2.3.4 Hold-up Capacitance

Usually bulk capacitors are placed on the output due to various reasons such as uninterrupted operation during power interruption or micro-short at the input, hold-up requirements for doing a memory dump before turning of the module and filtering requirements as well. This design considers minimum bulk capacitors requirements for meeting functional status "A" during LV124 E10 test case 2 100- μs input interruption. To achieve functional pass status A, acceptable voltage droop in the output of LM74810 is based on the UVLO settings of downstream DC-DC converters. For this design, 4.0-V drop in output voltage for 100 μs is considered and the minimum hold-up capacitance required is calculated by

$$C_{HOLD_UP_MIN} = \frac{I_{LOAD_MAX}}{dV_{OUT}} \times 100 \mu s \quad (3)$$

Minimum hold-up capacitance required to hold output with 4.0-V drop at 18-A current for 100 μs is 450 μF . A 470- μF electrolytic capacitor is a closest standard value that can be placed at the output. Note that the typical application circuit shows the hold-up capacitor as optional because not all designs require hold-up capacitance.

9.2.3.5 Overvoltage Protection and Battery Monitor

Resistors R_1 , R_2 and R_3 connected in series are used to program the overvoltage threshold and battery monitor ratio. The resistor values required for setting the overvoltage threshold V_{OV} to 37.0 V and battery monitor ratio $V_{BATT_MON} : V_{BATT}$ to 1:8 are calculated by solving [Equation 4](#) and [Equation 5](#).

$$V_{OVR} = \frac{R_3}{R_1 + R_2 + R_3} \times V_{OV} \quad (4)$$

$$V_{BAT_MON} = \frac{R_2 + R_3}{R_1 + R_2 + R_3} \times V_{BATT} \quad (5)$$

For minimizing the input current drawn from the battery through resistors R_1 , R_2 and R_3 , it recommended to use higher value of resistance. Using high value resistors will add error in the calculations because the current through the resistors at higher value will become comparable to the leakage current into the OV pin. Maximum leakage current into the OV pin is 1 μ A and choosing $(R_1 + R_2 + R_3) < 120$ k Ω ensures current through resistors is 100 times greater than leakage through OV pin.

Based on the device electrical characteristics, V_{OVR} is 1.23 V and battery monitor ratio (V_{BATT_MON} / V_{BATT}) is designed for a ratio of 1/8. To limit $(R_1 + R_2 + R_3) < 120$ k Ω , select $(R_1 + R_2) = 100$ k Ω . Solving [Equation 4](#) gives $R_3 = 3.45$ k Ω . Solving [Equation 5](#) for R_2 using $(R_1 + R_2) = 100$ k Ω and $R_3 = 3.45$ k Ω , gives $R_2 = 9.48$ k Ω and $R_1 = 90.52$ k Ω .

Standard 1% resistor values closest to the calculated resistor values are $R_1 = 90.9$ k Ω , $R_2 = 9.09$ k Ω and $R_3 = 3.48$ k Ω .

9.2.4 MOSFET Selection: Blocking MOSFET Q1

For selecting the blocking MOSFET Q1, important electrical parameters are the maximum continuous drain current I_D , the maximum drain-to-source voltage $V_{DS(MAX)}$, the maximum drain-to-source voltage $V_{GS(MAX)}$, the maximum source current through body diode and the drain-to-source ON resistance $R_{DS(ON)}$.

The maximum continuous drain current, I_D , rating must exceed the maximum continuous load current.

The maximum drain-to-source voltage, $V_{DS(MAX)}$, must be high enough to withstand the highest differential voltage seen in the application. This would include all the automotive transient events and any anticipated fault conditions. It is recommended to use MOSFETs with V_{DS} voltage rating of 60 V along with a single bidirectional TVS or a V_{DS} rating 40-V maximum rating along with two unidirectional TVS connected back-back at the input.

The maximum V_{GS} LM74810 can drive is 14 V, so a MOSFET with 15-V minimum V_{GS} rating should be selected. If a MOSFET with < 15 -V V_{GS} rating is selected, a zener diode can be used to clamp V_{GS} to safe level, but this would result in increased I_Q current.

To reduce the MOSFET conduction losses, lowest possible $R_{DS(ON)}$ is preferred, but selecting a MOSFET based on low $R_{DS(ON)}$ may not be beneficial always. Higher $R_{DS(ON)}$ will provide increased voltage information to LM74810's reverse comparator at a lower reverse current. Reverse current detection is better with increased $R_{DS(ON)}$. Choosing a MOSFET with < 50 -mV forward voltage drop at maximum current is a good starting point.

For active rectification of AC super imposed ripple on the battery supply voltage, gate-source charge Q_{GS} of Q1 must be selected to meet the required AC ripple frequency. Maximum gate-source charge Q_{GS} (at 4.5-V V_{GS}) for active rectification every cycle is

$$Q_{GS_MAX} = \frac{2.5\text{mA}}{F_{AC_RIPPLE}} \quad (6)$$

where 2.5 mA is minimum charge pump current at 7-V $V_{DGATE} - V_A$, F_{AC_RIPPLE} is frequency of the AC ripple superimposed on the battery and Q_{GS_MAX} is the Q_{GS} value specified in manufacturer datasheet at 6-V V_{GS} . For active rectification at $F_{AC_RIPPLE} = 30$ KHz, $Q_{GS_MAX} = 83$ nC. Further for active rectification at $F_{AC_RIPPLE} = 200$ KHz, $Q_{GS_MAX} = 12.5$ nC.

Based on the design requirements, BUK9J0R9-40H MOSFET is selected and its ratings are:

- 40-V $V_{DS(MAX)}$ and 16-V $V_{GS(MAX)}$
- $R_{DS(ON)}$ 0.97-m Ω typical at 4.5-V V_{GS} and 0.82 m Ω rated at 10-V V_{GS}
- MOSFET Q_{GS_MAX} 30.2 nC

Thermal resistance of the MOSFET should be considered against the expected maximum power dissipation in the MOSFET to ensure that the junction temperature (T_J) is well controlled.

9.2.5 MOSFET Selection: Hot-Swap MOSFET Q2

The V_{DS} rating of the MOSFET Q2 should be sufficient to handle the maximum system voltage along with the input transient voltage. For this 12-V design, transient overvoltage events are during suppressed load dump 35 V 400 ms and ISO 7637-2 pulse 2 A 50 V for 50 μ s. Further, ISO 7637-2 Pulse 3B is a very fast repetitive pulse of 100 V 100 ns that is usually absorbed by the input and output ceramic capacitors and the maximum voltage on the 12-V battery can be limited to < 40 V the minimum recommended input capacitance of 0.1 μ F. The 50-V ISO 7637-2 Pulse 2 A can also be absorbed by input and output capacitors and its amplitude could be reduced to 40-V peak by placing sufficient amount of capacitance at input and output. For this 12-V design, a 40-V V_{DS} rated MOSFET is selected.

The V_{GS} rating of the MOSFET Q2 should be higher than that maximum HGATE-OUT voltage 15 V.

Inrush current through the MOSFET during input hot-plug into the 12-V battery is determined by output capacitance. External capacitor on HGATE, $C_{D\text{VDT}}$ is used to limit the inrush current during input hot-plug or startup. The value of inrush current determined by Equation 2 need to be selected to ensure that the MOSFET Q2 is operating well within its safe operating area (SOA). Considering $C_{OUT} = 470$ μ F and inrush current of 2.5 A, the calculated value of $C_{D\text{VDT}}$ is 9.96 nF. Closest standard value of 10.0 nF is chosen for this design.

Duration of inrush current is calculated by:

$$dT_{INRUSH} = \frac{12}{I_{INRUSH}} \times C_{OUT} \quad (7)$$

Calculated inrush current duration is 2.36 ms with 2.5-A inrush current.

MOSFET BUK9J0R9-40H having 40-V V_{DS} and 16 V V_{GS} rating is selected for Q2. Power dissipation during inrush is well within the MOSFET's safe operating area (SOA).

9.2.6 TVS selection

For 40-V rated MOSFET, two bi-directional 600-W SMBJ TVS, SMBJ33A and SMBJ16A are recommended for input transient clamping and protection. For detailed explanation on TVS selection for 12-V battery systems, refer to [TVS Selection for 12-V Battery Systems](#) and refer to [TVS Selection for 24-V Battery Systems](#) for 24-V battery systems.

9.2.7 Application Curves

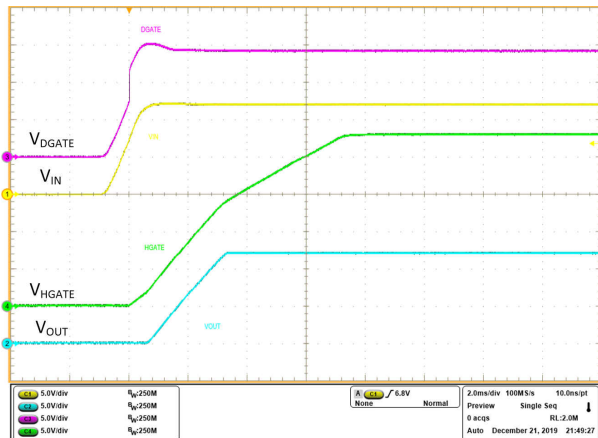


Figure 9-2. Startup 12 V with EN pulled to VIN

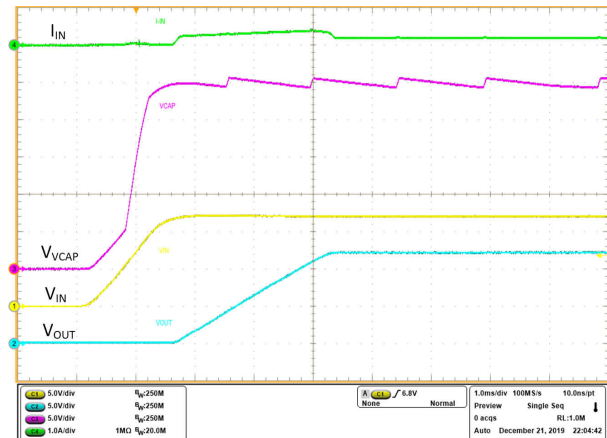


Figure 9-3. Startup 12 V showing Charge Pump VCAP

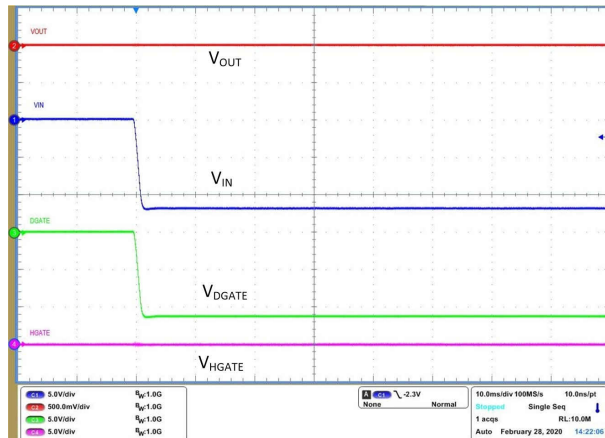


Figure 9-4. Reverse Input Voltage -12 V

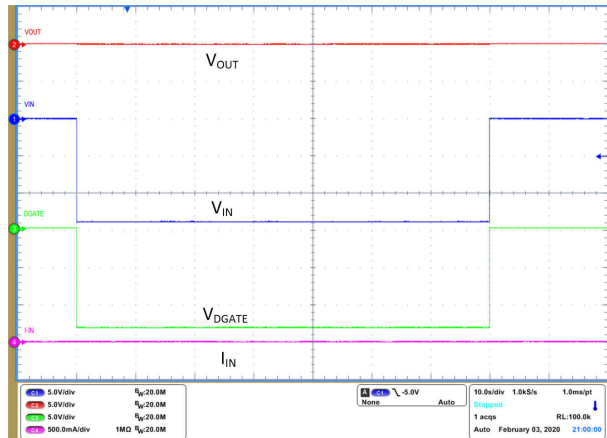


Figure 9-5. Reverse Input Voltage -12 V for 60s

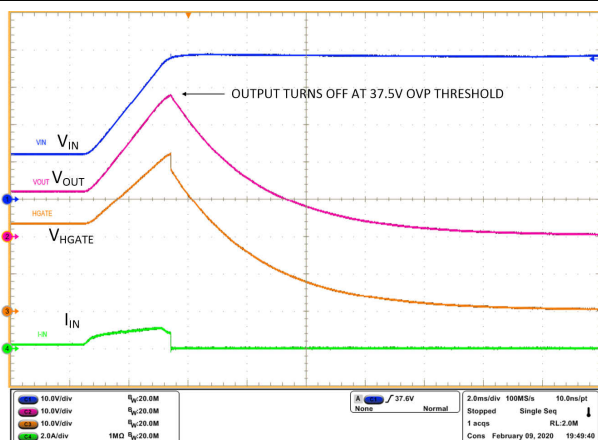


Figure 9-6. Overvoltage Cut-off

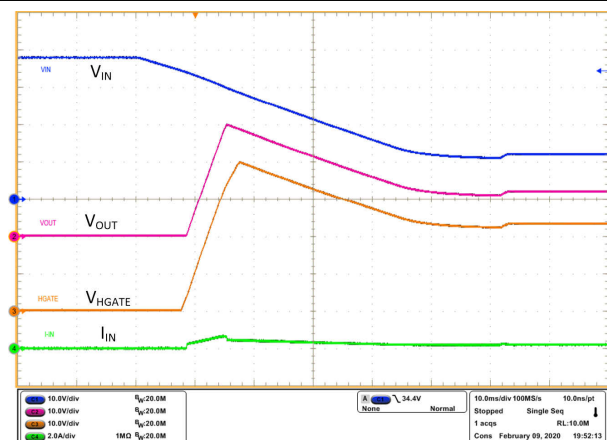


Figure 9-7. Overvoltage Recovery

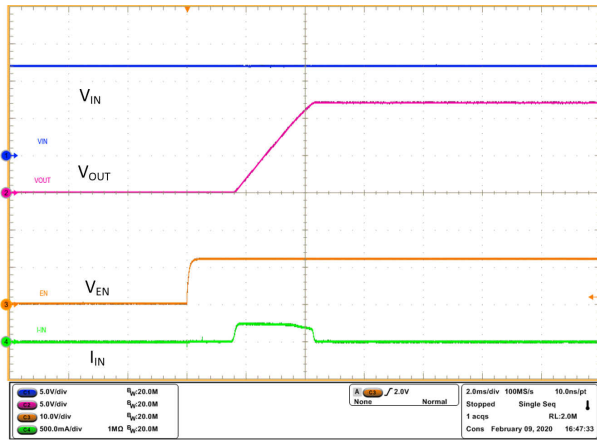


Figure 9-8. Turn ON with ENABLE Control

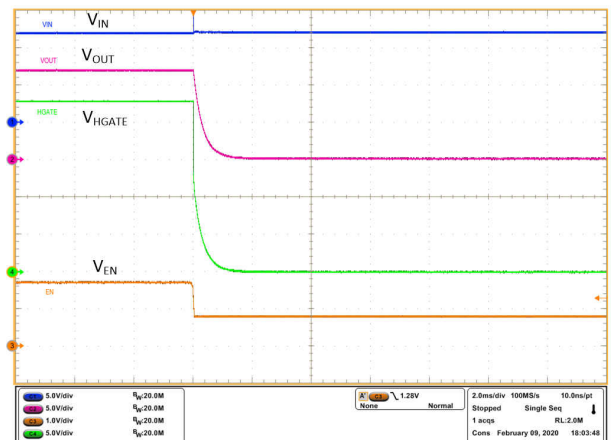


Figure 9-9. Turn OFF with ENABLE Control

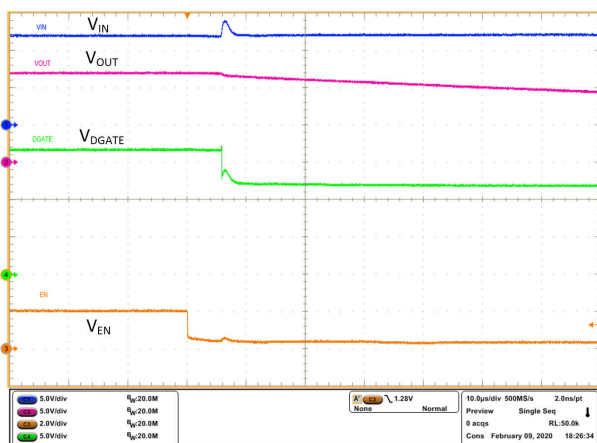


Figure 9-10. Disable Delay DGATE

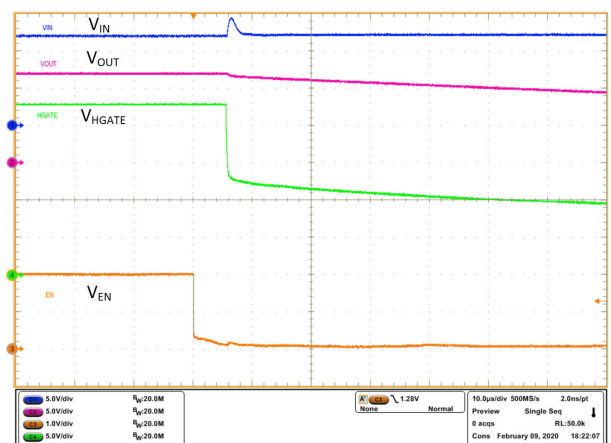


Figure 9-11. Disable Delay HGATE

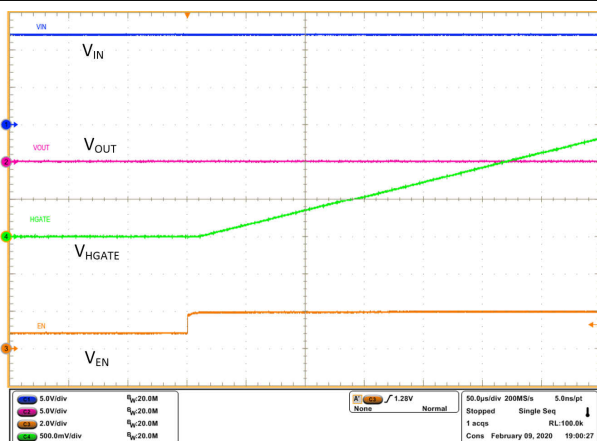


Figure 9-12. Enable Delay HGATE

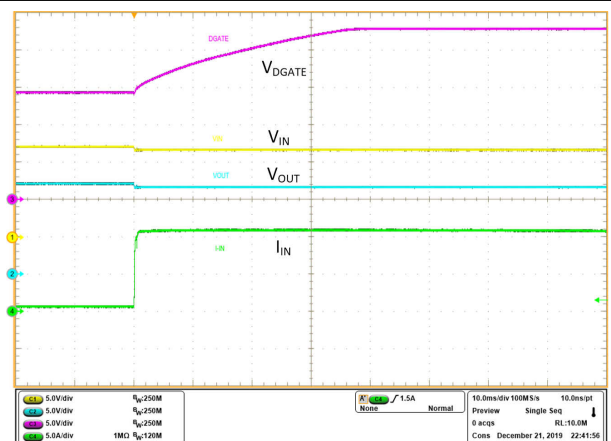


Figure 9-13. Load Transient Response DGATE

9.3 Do's and Don'ts

Leave exposed pad (RTN) of the IC floating. Do not connect it to the GND plane. Connecting RTN to GND disables the Reverse Polarity protection feature.

9.4 Power Supply Recommendations

9.4.1 Transient Protection

When the external MOSFETs turn OFF during the conditions such as overvoltage cut-off, reverse current blocking, EN/UVLO causing an interruption of the current flow, the input line inductance generates a positive voltage spike on the input and output inductance generates a negative voltage spike on the output. The peak amplitude of voltage spikes (transients) depends on the value of inductance in series to the input or output of the device. These transients can exceed the *Absolute Maximum Ratings* of the device if steps are not taken to address the issue.

Typical methods for addressing transients include:

- Minimizing lead length and inductance into and out of the device
- Using large PCB GND plane
- Use of a Schottky diode across the output and GND to absorb negative spikes
- A low value ceramic capacitor ($C_{(IN)}$) to approximately 0.1 μF) to absorb the energy and dampen the transients.

The approximate value of input capacitance can be estimated with [Equation 8](#).

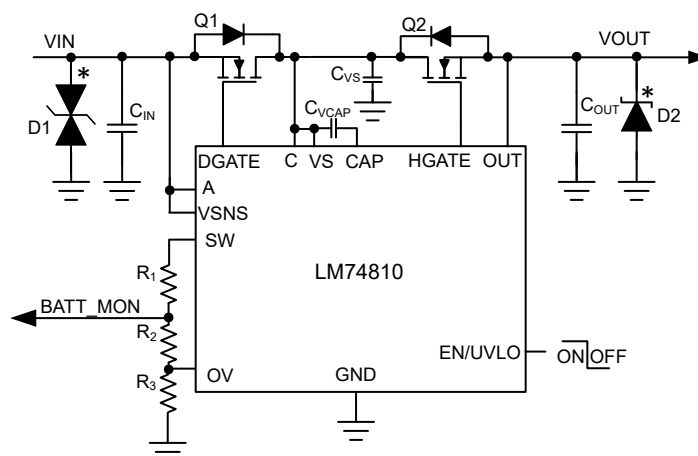
$$V_{\text{spike(Absolute)}} = V_{(IN)} + I_{(Load)} \times \sqrt{\frac{L_{(IN)}}{C_{(IN)}}} \quad (8)$$

where

- $V_{(IN)}$ is the nominal supply voltage
- $I_{(LOAD)}$ is the load current
- $L_{(IN)}$ equals the effective inductance seen looking into the source
- $C_{(IN)}$ is the capacitance present at the input

Some applications may require additional Transient Voltage Suppressor (TVS) to prevent transients from exceeding the *Absolute Maximum Ratings* of the device. These transients can occur during EMC testing such as automotive ISO7637 pulses.

The circuit implementation with optional protection components (a ceramic capacitor, TVS and schottky diode) is shown in [Figure 9-14](#)



* Optional components needed for suppression of transients

Figure 9-14. Circuit Implementation with Optional Protection Components for LM7481

9.4.2 TVS Selection for 12-V Battery Systems

In selecting the TVS, important specifications are breakdown voltage and clamping voltage. The breakdown voltage of the TVS+ should be higher than 24-V jump start voltage and 35-V suppressed load dump voltage and less than the maximum ratings of LM7481 (65 V). The breakdown voltage of TVS- should be beyond than maximum reverse battery voltage –16 V, so that the TVS- is not damaged due to long time exposure to reverse connected battery.

Clamping voltage is the voltage the TVS diode clamps in high current pulse situations and this voltage is much higher than the breakdown voltage. In the case of an ISO 7637-2 pulse 1, the input voltage goes up to –150 V with a generator impedance of 10 Ω . This translates to 15 A flowing through the TVS - and the voltage across the TVS would be close to its clamping voltage.

The next criterion is that the absolute maximum rating of cathode to anode voltage of the LM7481 (85 V) and the maximum V_{DS} rating MOSFET are not exceeded. In the design example, 40-V rated MOSFET is chosen and maximum limit on the cathode to anode voltage is 40 V.

During ISO 7637-2 pulse 1, the anode of LM7481 is pulled down by the ISO pulse, clamped by TVS- and the MOSFET Q1 is turned off quickly to prevent reverse current from discharging the bulk output capacitors. When the MOSFET turns off, the cathode to anode voltage seen is equal to (TVS Clamping voltage + Output capacitor voltage). If the maximum voltage on output capacitor is 16 V (maximum battery voltage), then the clamping voltage of the TVS- should not exceed, $(40\text{ V} - 16\text{ V}) = -24\text{ V}$.

On the positive side, the SMBJ33A TVS diode can be used for 12-V battery protection application. The breakdown voltage of 36.7 V meets the jump start, load dump requirements on the positive side. On the negative side, TVS has to withstand 16-V reverse battery connection and clamping voltage has to be $-(40\text{ V} - 16\text{ V}) = -24\text{ V}$. SMBJ16A can be used.

However if 60-V rated MOSFET is selected, a single bi-directional TVS SMBJ33CA is recommended. SMBJ series of TVS' are rated up to 600-W peak pulse power levels and are sufficient for ISO 7637-2 pulses.

9.4.3 TVS Selection for 24-V Battery Systems

For 24-V battery protection application, the TVS and MOSFET Q1 and Q2 needs to be changed to suit 24-V battery requirements.

The breakdown voltage of the TVS+ should be higher than 48-V jump start voltage, less than the absolute maximum ratings of anode and enable pin of LM74810 (70 V) and should withstand 65-V suppressed load dump. The breakdown voltage of TVS- should be lower than maximum reverse battery voltage –32 V, so that the TVS- is not damaged due to long time exposure to reverse connected battery.

During ISO 7637-2 pulse 1, the input voltage goes up to –600 V with a generator impedance of 50 Ω . This translates to 12-A flowing through the TVS-. The clamping voltage of the TVS- cannot be same as that of 12-V battery protection circuit because during the ISO 7637-2 pulse, the Anode to Cathode voltage seen is equal to (-TVS Clamping voltage + Output capacitor voltage). For 24-V battery application, the maximum battery voltage is 32 V, then the clamping voltage of the TVS- should not exceed, $85\text{ V} - 32\text{ V} = 53\text{ V}$.

Single bi-directional TVS cannot be used for 24-V battery protection because breakdown voltage for TVS+ $\geq 65\text{ V}$, maximum clamping voltage is $\leq 53\text{ V}$ and the clamping voltage cannot be less than the breakdown voltage. Two un-directional TVS connected back-back needs to be used at the input. For positive side TVS+, SMBJ58A with the breakdown voltage of 64.4 V (minimum), 67.8 (typical) is recommended. For the negative side TVS-, SMBJ28A with breakdown voltage close to 32 V (to withstand maximum reverse battery voltage –32 V) and maximum clamping voltage of 42.1 V is recommended.

For 24-V battery protection, a 75-V rated MOSFET is recommended to be used along with SMBJ28A and SMBJ58A connected back-back at the input.

9.5 Layout

9.5.1 Layout Guidelines

- For the ideal diode stage, connect A, DGATE and C pins of LM7481 close to the MOSFET's SOURCE, GATE and DRAIN pins.
- For the load disconnect stage, connect HGATE and OUT pins of LM7481 close to the MOSFET's GATE and SOURCE pins.
- The high current path of for this solution is through the MOSFET, therefore it is important to use thick and short traces for source and drain of the MOSFET to minimize resistive losses.
- The DGATE pin of the LM7481 must be be connected to the MOSFET GATE with short trace.
- Place transient suppression components close to LM7481.
- Place the decoupling capacitor, C_{VS} close to VS pin and chip GND.
- The charge pump capacitor across CAP and VS pins must be kept away from the MOSFET to lower the thermal effects on the capacitance value.
- Obtaining acceptable performance with alternate layout schemes is possible, however the layout shown in the [Layout Example](#) is intended as a guideline and to produce good results.

9.5.2 Layout Example

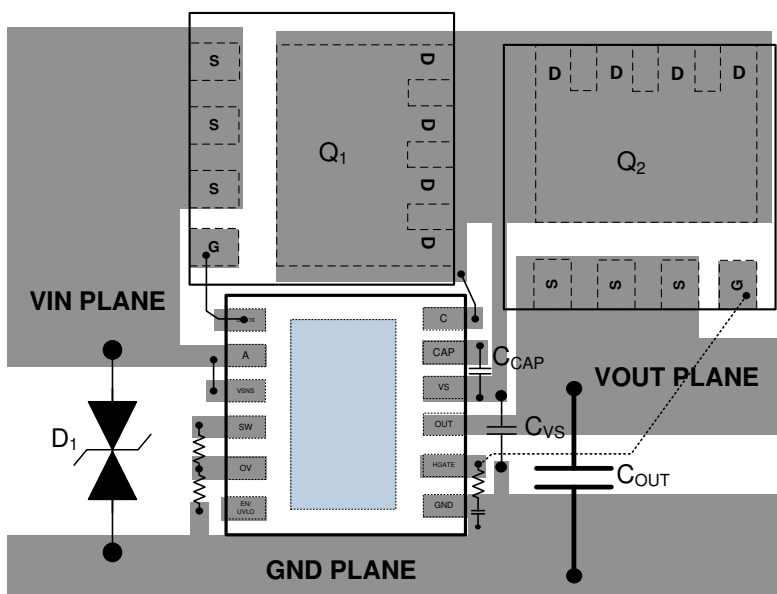


Figure 9-15. PCB Layout Example

10 Device and Documentation Support

10.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](https://www.ti.com). Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

10.2 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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10.3 Trademarks

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10.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.5 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LM74810MDRRR	ACTIVE	WSO	DRR	12	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	T74810	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSELETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF LM7481 :

- Automotive : [LM7481-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TAPE AND REEL INFORMATION



*All dimensions are nominal

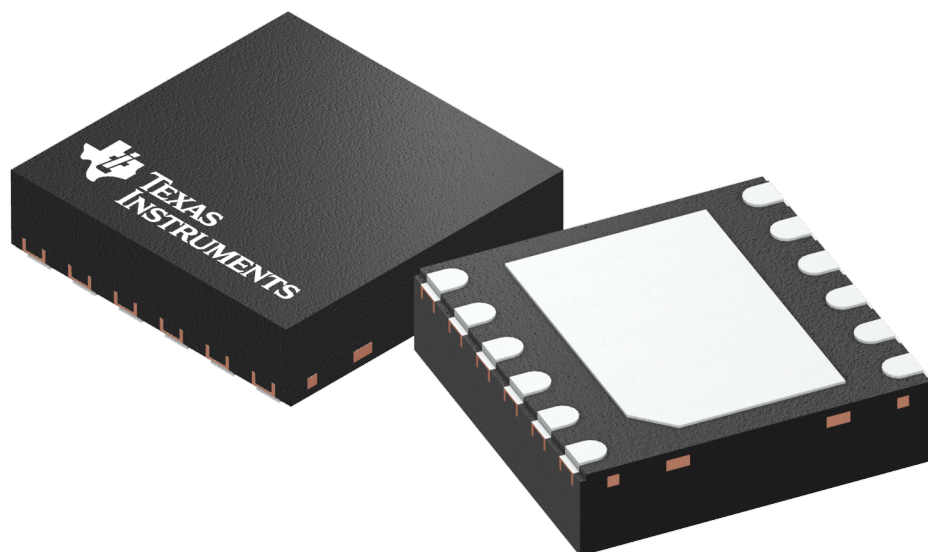
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LM74810MDRRR	WSO	DRR	12	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS

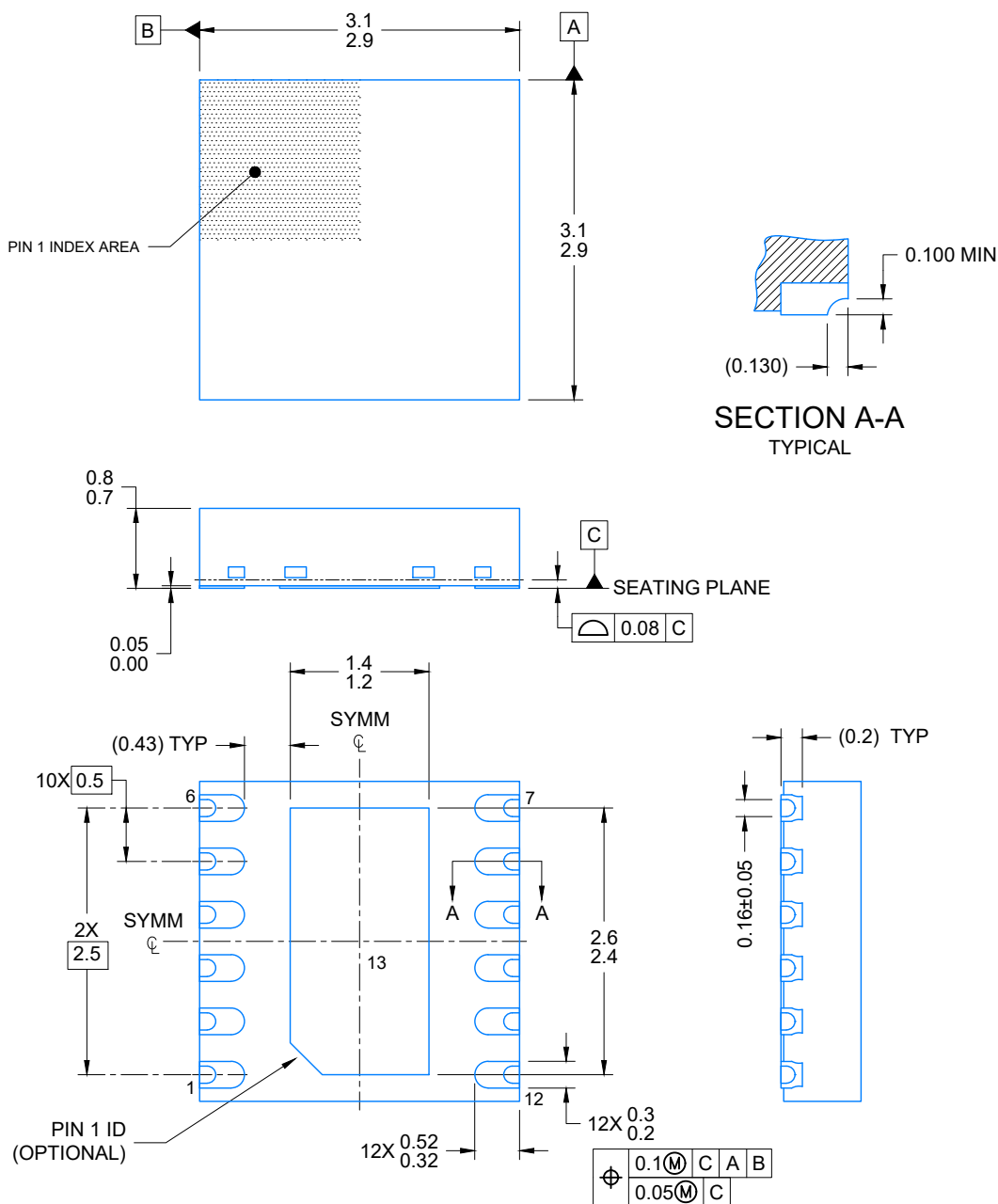


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LM74810MDRRR	WSON	DRR	12	3000	367.0	367.0	35.0



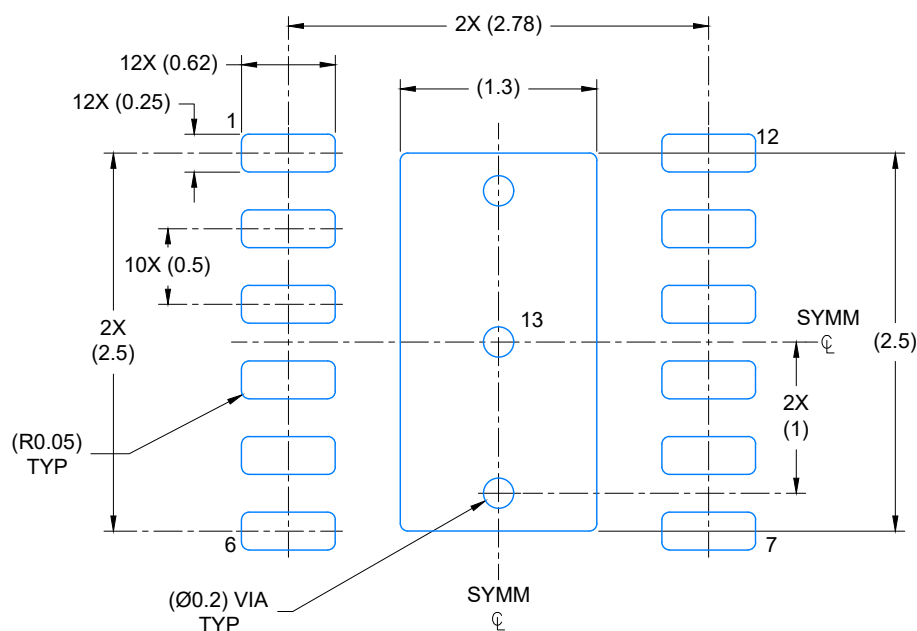
Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



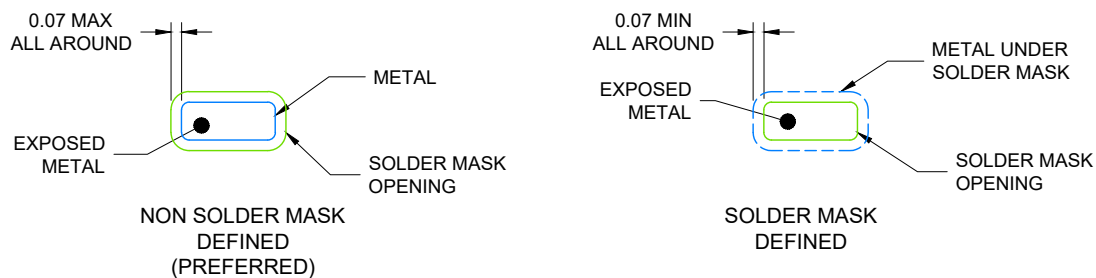
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NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 20X

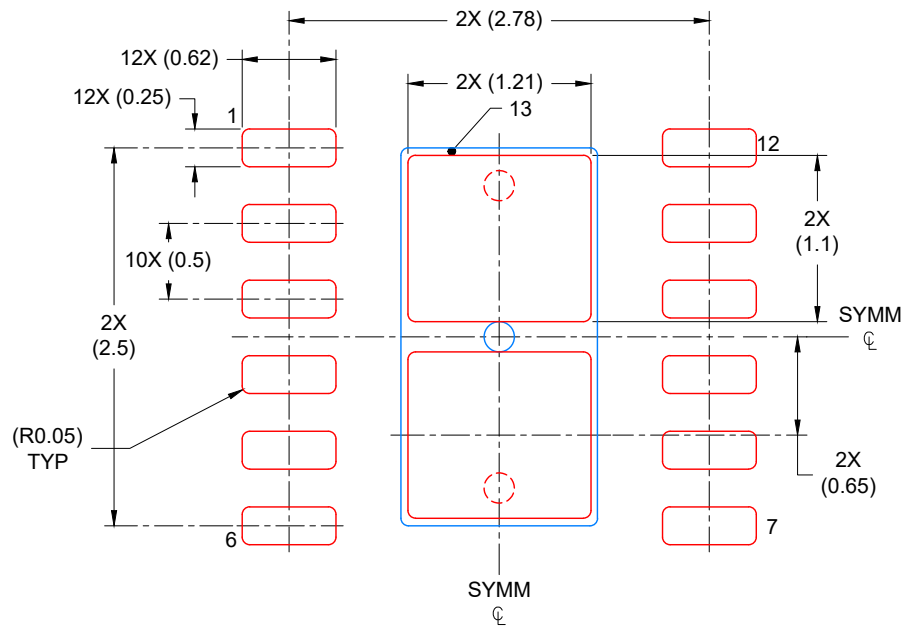


SOLDER MASK DETAILS

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NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
82% PRINTED COVERAGE BY AREA
SCALE: 20X

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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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